

Notice of References Cited

Application/Control No.

10/566,730

Applicant(s)/Patent Under
Reexamination
TANAKA ET AL.

Examiner

MARK EASHOO

Art Unit

1796

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,580,942	12-1996	Cornish, Katrinia	528/1
	B	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Cornish et al., Enc. Poly. Sci. and Tech., 2004, (John Wiley and Sons)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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